Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,245	POLIVKA ET AL.
Examiner	Art Unit
TUYEN T. NGUYEN	2832

SEARCHED				
Subclass	Date	Examiner		
65, 83, 183, 192, 200, 220- 223	4/30/2005	TTN		
-				
	Subclass 65, 83, 183, 192, 200, 220-	Subclass Date  65, 83, 183, 192, 200, 220-  4/30/2005		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARC (INCLUDING SE	H NOTES ARCH STRATEG	Y)
	DATE	EXMR
		1
		_
		ļ
		_
399		